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TS-00-749

April 17, 2003

To: Commissioner of Patents and Trademarks
Washington, D.C. 20231

Fr: Stephen B. Ackerman, Reg. No. 37,761
28 Davis Avenue
Poughkeepsie, N.Y. 12603

6B Anot
M. Brunson
5/2/03

Subject:

Serial No. 10/056,978 01/25/02

Y. D. CHIH ET AL

"METHOD OF MARGINAL ERASURE FOR THE
TESTING OF FLASH MEMORIES"

Grp. Art Unit: 2818 TRONG Q. PHAN

Do not enter
TP
5/6/03

entered
6/10/03
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TC 2800 MAIL ROOM

RESPONSE FINAL PATENT OFFICE ACTION

Dear Sir:

In response to the Office Action dated January 24, 2003, please amend the above-identified application for patent as follows:

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner of Patents and Trademarks, Washington, D.C. 20231, on April 24, 2003.

Rosemary L. S. Pike, Reg. No. 39,332

Signature Rosemary L. S. Pike
Date April 24, 2003